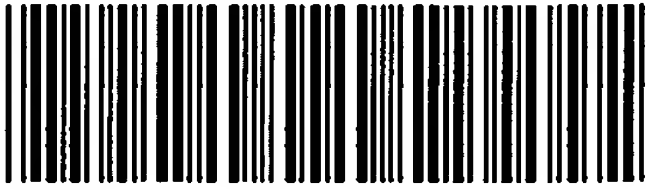


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/646,012	DEVLIN ET AL.	
	Examiner	Art Unit	
	David E. Martinez	2181	

SEARCHED			
Class	Subclass	Date	Examiner
710	68-71	5/2/2006	DM
386	109	5/2/2006	DM

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East see attached	5/2/2006	DM
Tammara Peyton	5/2/2006	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, Derwent, IBM_TDB.	5/2/2006	DM